

Complementary Silicon Power Transistors

... designed for general-purpose switching and amplifier applications.

- DC Current Gain — $h_{FE} = 20-70 @ I_C = 4 \text{ Adc}$
- Collector-Emitter Saturation Voltage —
 $V_{CE(sat)} = 1.1 \text{ Vdc (Max) @ } I_C = 4 \text{ Adc}$
- Excellent Safe Operating Area

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V_{CEO}	60	Vdc
Collector-Emitter Voltage	V_{CER}	70	Vdc
Collector-Base Voltage	V_{CB}	100	Vdc
Emitter-Base Voltage	V_{EB}	7	Vdc
Collector Current — Continuous	I_C	15	A _{dc}
Base Current	I_B	7	A _{dc}
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	115 0.657	Watts W/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J, T_{stg}	-65 to +200	$^\circ\text{C}$

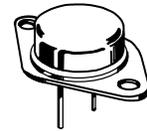
THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	1.52	$^\circ\text{C/W}$

NPN
2N3055 *
PNP
MJ2955 *

*Motorola Preferred Device

15 AMPERE
POWER TRANSISTORS
COMPLEMENTARY
SILICON
60 VOLTS
115 WATTS



CASE 1-07
TO-204AA
(TO-3)

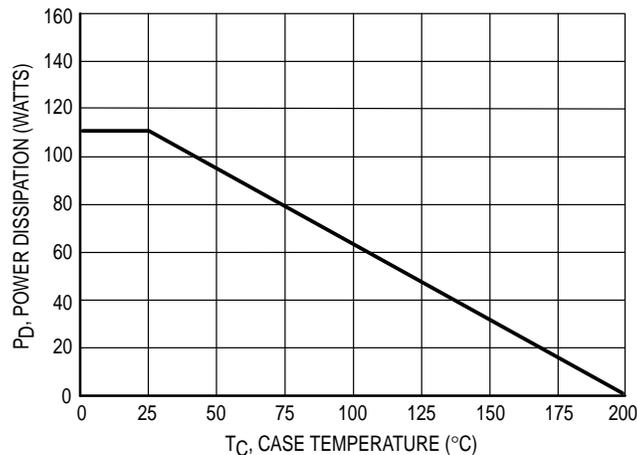


Figure 1. Power Derating

Preferred devices are Motorola recommended choices for future use and best overall value.

2N3055 MJ2955

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
*OFF CHARACTERISTICS				
Collector–Emitter Sustaining Voltage (1) ($I_C = 200\text{ mAdc}$, $I_B = 0$)	$V_{CEO(sus)}$	60	—	Vdc
Collector–Emitter Sustaining Voltage (1) ($I_C = 200\text{ mAdc}$, $R_{BE} = 100\text{ Ohms}$)	$V_{CER(sus)}$	70	—	Vdc
Collector Cutoff Current ($V_{CE} = 30\text{ Vdc}$, $I_B = 0$)	I_{CEO}	—	0.7	mAcd
Collector Cutoff Current ($V_{CE} = 100\text{ Vdc}$, $V_{BE(off)} = 1.5\text{ Vdc}$) ($V_{CE} = 100\text{ Vdc}$, $V_{BE(off)} = 1.5\text{ Vdc}$, $T_C = 150^\circ\text{C}$)	I_{CEX}	—	1.0 5.0	mAcd
Emitter Cutoff Current ($V_{BE} = 7.0\text{ Vdc}$, $I_C = 0$)	I_{EBO}	—	5.0	mAcd

*ON CHARACTERISTICS (1)

DC Current Gain ($I_C = 4.0\text{ Adc}$, $V_{CE} = 4.0\text{ Vdc}$) ($I_C = 10\text{ Adc}$, $V_{CE} = 4.0\text{ Vdc}$)	h_{FE}	20 5.0	70 —	—
Collector–Emitter Saturation Voltage ($I_C = 4.0\text{ Adc}$, $I_B = 400\text{ mAcd}$) ($I_C = 10\text{ Adc}$, $I_B = 3.3\text{ Adc}$)	$V_{CE(sat)}$	—	1.1 3.0	Vdc
Base–Emitter On Voltage ($I_C = 4.0\text{ Adc}$, $V_{CE} = 4.0\text{ Vdc}$)	$V_{BE(on)}$	—	1.5	Vdc

SECOND BREAKDOWN

Second Breakdown Collector Current with Base Forward Biased ($V_{CE} = 40\text{ Vdc}$, $t = 1.0\text{ s}$, Nonrepetitive)	$I_{s/b}$	2.87	—	Adc
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DYNAMIC CHARACTERISTICS

Current Gain — Bandwidth Product ($I_C = 0.5\text{ Adc}$, $V_{CE} = 10\text{ Vdc}$, $f = 1.0\text{ MHz}$)	f_T	2.5	—	MHz
*Small–Signal Current Gain ($I_C = 1.0\text{ Adc}$, $V_{CE} = 4.0\text{ Vdc}$, $f = 1.0\text{ kHz}$)	h_{fe}	15	120	—
*Small–Signal Current Gain Cutoff Frequency ($V_{CE} = 4.0\text{ Vdc}$, $I_C = 1.0\text{ Adc}$, $f = 1.0\text{ kHz}$)	f_{hfe}	10	—	kHz

* Indicates Within JEDEC Registration. (2N3055)

(1) Pulse Test: Pulse Width $\leq 300\text{ }\mu\text{s}$, Duty Cycle $\leq 2.0\%$.

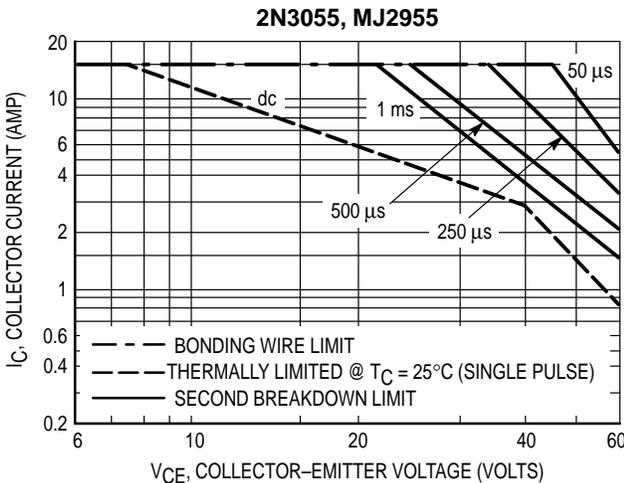


Figure 2. Active Region Safe Operating Area

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 2 is based on $T_C = 25^\circ\text{C}$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated for temperature according to Figure 1.

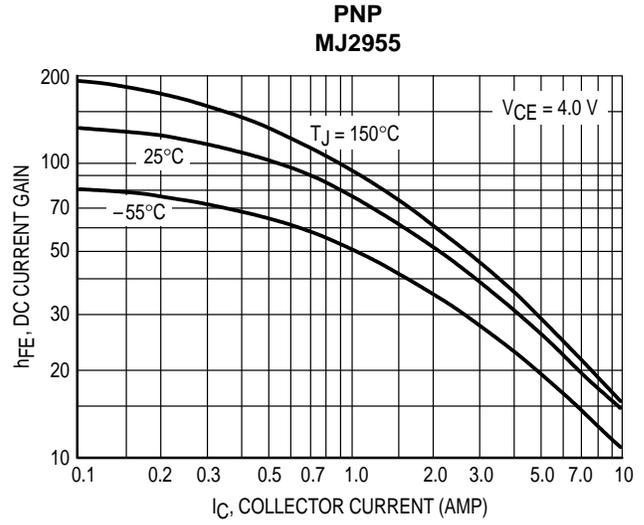
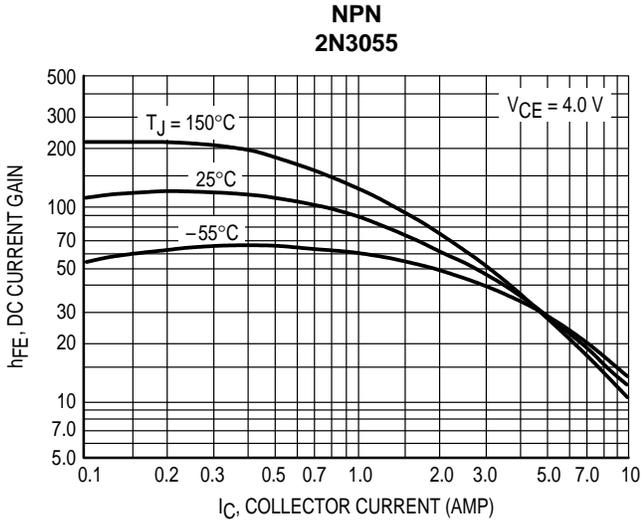


Figure 3. DC Current Gain

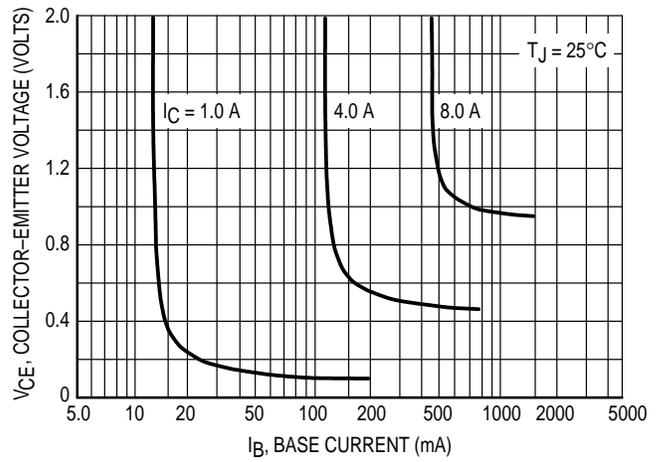
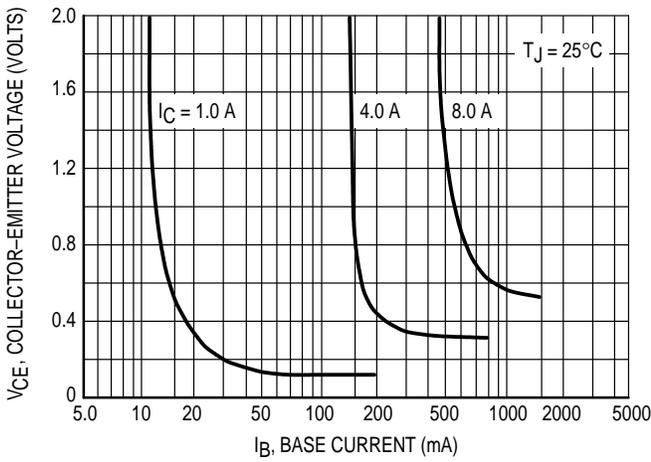


Figure 4. Collector Saturation Region

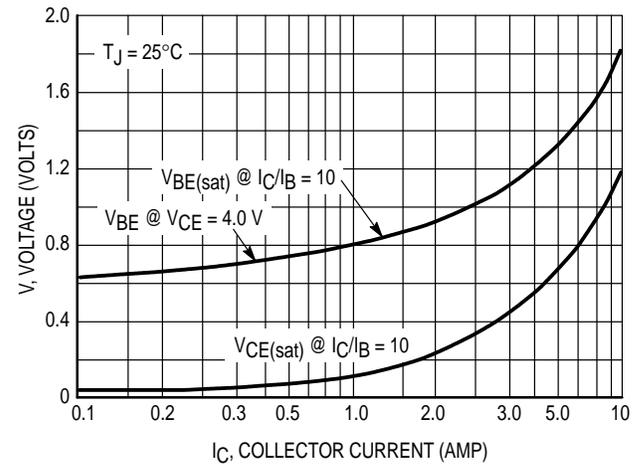
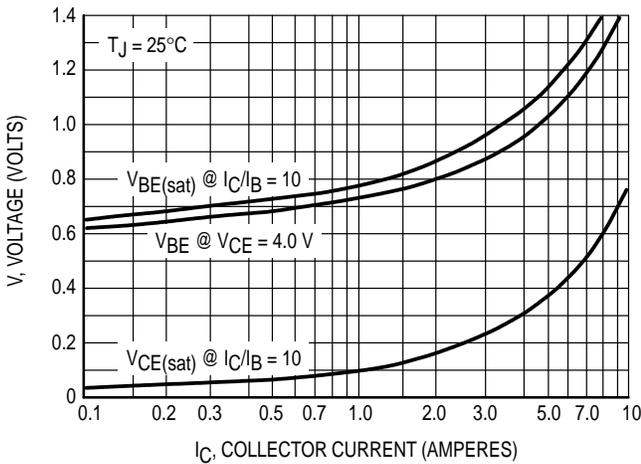
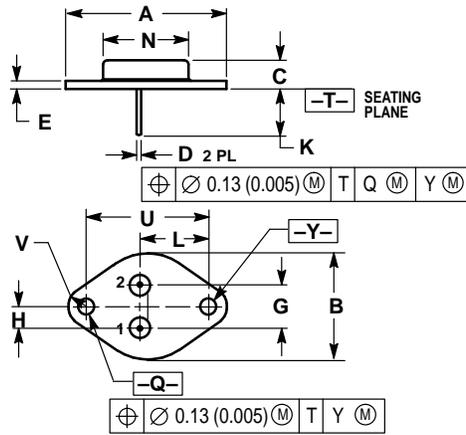


Figure 5. "On" Voltages

PACKAGE DIMENSIONS



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. ALL RULES AND NOTES ASSOCIATED WITH REFERENCED TO-204AA OUTLINE SHALL APPLY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.550 REF		39.37 REF	
B	—	1.050	—	26.67
C	0.250	0.335	6.35	8.51
D	0.038	0.043	0.97	1.09
E	0.055	0.070	1.40	1.77
G	0.430 BSC		10.92 BSC	
H	0.215 BSC		5.46 BSC	
K	0.440	0.480	11.18	12.19
L	0.665 BSC		16.89 BSC	
N	—	0.830	—	21.08
Q	0.151	0.165	3.84	4.19
U	1.187 BSC		30.15 BSC	
V	0.131	0.188	3.33	4.77

- STYLE 1:
 PIN 1: BASE
 2: EMITTER
 CASE: COLLECTOR

CASE 1-07
 TO-204AA (TO-3)
 ISSUE Z

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Datasheets for electronics components.

PNP POWER SILICON TRANSISTOR

Qualified per MIL-PRF-19500/514

Devices

2N6274

2N6277

Qualified Level

JAN
JANTX
JANTXV

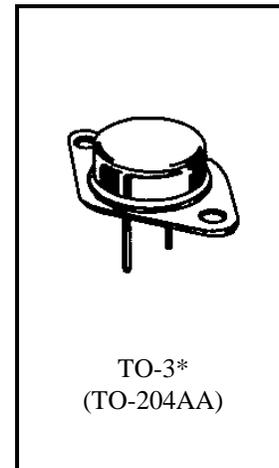
MAXIMUM RATINGS

Ratings	Symbol	2N6274	2N6277	Unit
Collector-Emitter Voltage	V_{CEO}	100	150	Vdc
Collector-Base Voltage	V_{CBO}	120	180	Vdc
Emitter-Base Voltage	V_{EBO}	6.0		Vdc
Base Current	I_B	20		Adc
Collector Current	I_C	50		Adc
Total Power Dissipation	P_T	@ $T_C = +25^{\circ}C$ (1)	250	W
		@ $T_C = +100^{\circ}C$ (2)	143	W
Operating & Storage Junction Temperature Range	T_j, T_{stg}	-65 to +200		$^{\circ}C$

THERMAL CHARACTERISTICS

Characteristics	Symbol	Max.	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.7	$^{\circ}C/W$

1) Derate linearly 1.43 W/ $^{\circ}C$ between $T_C = +25^{\circ}C$ and $T_C = +200^{\circ}C$



*See appendix A for package outline

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Characteristics	Symbol	Min.	Max.	Unit
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OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage $I_C = 50$ mAdc	2N6274 2N6277	$V_{(BR)CEO}$	100 150	Vdc
Collector-Emitter Cutoff Current $V_{CE} = 50$ Vdc $V_{CE} = 75$ Vdc	2N6274 2N6277	I_{CEO}	50 50	μ Adc
Collector-Emitter Cutoff Current $V_{CE} = 120$ Vdc, $V_{BE} = -1.5$ Vdc $V_{CE} = 180$ Vdc, $V_{BE} = -1.5$ Vdc	2N6274 2N6277	I_{CEX}	10 10	μ Adc
Emitter-Base Cutoff Current $V_{EB} = 6.0$ Vdc		I_{EBO}	100	μ Adc
Collector-Base Cutoff Current $V_{CB} = 120$ Vdc $V_{CB} = 180$ Vdc	2N6274 2N6277	I_{CBO}	10 10	μ Adc

2N6274, 2N6277 JAN SERIES

ELECTRICAL CHARACTERISTICS (con't)

Characteristics	Symbol	Min.	Max.	Unit
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ON CHARACTERISTICS ⁽²⁾

Forward-Current Transfer Ratio I _C = 1.0 Adc, V _{CE} = 4.0 Vdc I _C = 20 Adc, V _{CE} = 4.0 Vdc I _C = 50 Adc, V _{CE} = 4.0 Vdc	h _{FE}	50 30 10	120	
Collector-Emitter Saturation Voltage I _C = 20 Adc, I _B = 2.0 Adc I _C = 50 Adc, I _B = 10 Adc	V _{CE(sat)}		1.0 3.0	Vdc
Base-Emitter Saturation Voltage I _C = 20 Adc, I _B = 2.0 Adc	V _{BE(sat)}		1.8	Vdc

DYNAMIC CHARACTERISTICS

Magnitude of Common Emitter Small-Signal Short-Circuit Forward Current Transfer Ratio I _C = 1.0 Adc, V _{CE} = 10 Vdc, f = 10 MHz	h _{fe}	3.0	12	
Output Capacitance V _{CB} = 10 Vdc, I _E = 0, f = 1.0 MHz	C _{obo}		600	pF

SWITCHING CHARACTERISTICS

Turn-On Time V _{CC} = 80 Vdc; I _C = 20 Adc; I _B = 2.0 Adc	t _{on}		0.5	μs
Turn-Off Time V _{CC} = 80 Vdc; I _C = 20 Adc; I _{B1} = -I _{B2} = 2.0 Adc	t _{off}		1.05	μs

SAFE OPERATING AREA

DC Tests T _C = +25°C, 1 Cycle, t = 1.0 s		
Test 1 V _{CE} = 5.0 Vdc, I _C = 50 Adc	All Types	
Test 2 V _{CE} = 8.6 Vdc, I _C = 165 mAdc	All Types	
Test 3 V _{CE} = 80 Vdc, I _C = 29 mAdc	2N6274	
Test 4 V _{CE} = 120 Vdc, I _C = 110 mAdc	2N6277	

(2) Pulse Test: Pulse Width = 300μs, Duty Cycle ≤ 2.0%.

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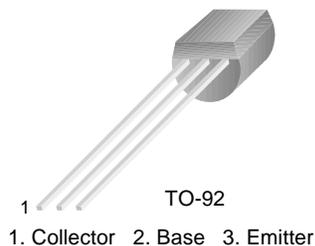
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Datasheets for electronics components.

BC337/338

Switching and Amplifier Applications

- Suitable for AF-Driver stages and low power output stages
- Complement to BC327/BC328



NPN Epitaxial Silicon Transistor

Absolute Maximum Ratings $T_a=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Value	Units
V_{CES}	Collector-Emitter Voltage		
	: BC337	50	V
	: BC338	30	V
V_{CEO}	Collector-Emitter Voltage		
	: BC337	45	V
	: BC338	25	V
V_{EBO}	Emitter-Base Voltage	5	V
I_C	Collector Current (DC)	800	mA
P_C	Collector Power Dissipation	625	mW
T_J	Junction Temperature	150	$^\circ\text{C}$
T_{STG}	Storage Temperature	-55 ~ 150	$^\circ\text{C}$

Electrical Characteristics $T_a=25^\circ\text{C}$ unless otherwise noted

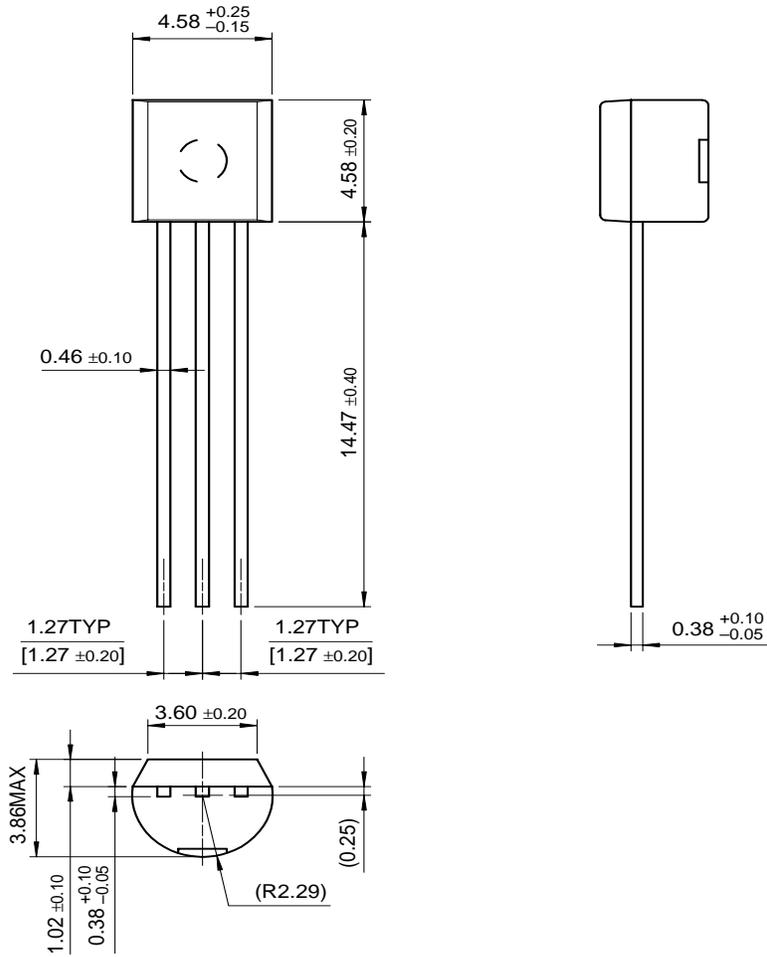
Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
BV_{CEO}	Collector-Emitter Breakdown Voltage	$I_C=10\text{mA}, I_B=0$	45			V
			25			V
BV_{CES}	Collector-Emitter Breakdown Voltage	$I_C=0.1\text{mA}, V_{BE}=0$	50			V
			30			V
BV_{EBO}	Emitter-Base Breakdown Voltage	$I_E=0.1\text{mA}, I_C=0$	5			V
I_{CES}	Collector Cut-off Current	$V_{CE}=45\text{V}, I_B=0$ $V_{CE}=25\text{V}, I_B=0$		2	100	nA
				2	100	nA
h_{FE1}	DC Current Gain	$V_{CE}=1\text{V}, I_C=100\text{mA}$ $V_{CE}=1\text{V}, I_C=300\text{mA}$	100		630	
h_{FE2}			60			
$V_{CE}(\text{sat})$	Collector-Emitter Saturation Voltage	$I_C=500\text{mA}, I_B=50\text{mA}$			0.7	V
$V_{BE}(\text{on})$	Base Emitter On Voltage	$V_{CE}=1\text{V}, I_C=300\text{mA}$			1.2	V
f_T	Current Gain Bandwidth Product	$V_{CE}=5\text{V}, I_C=10\text{mA}, f=50\text{MHz}$		100		MHz
C_{ob}	Output Capacitance	$V_{CB}=10\text{V}, I_E=0, f=1\text{MHz}$		12		pF

h_{FE} Classification

Classification	16	25	40
h_{FE1}	100 ~ 250	160 ~ 400	250 ~ 630
h_{FE2}	60-	100-	170-

Package Dimensions

TO-92



Dimensions in Millimeters

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

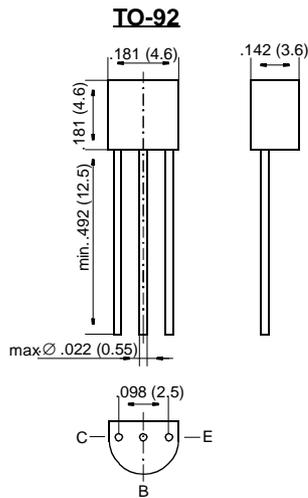
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Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

BC327, BC328

Small Signal Transistors (PNP)



Dimensions in inches and (millimeters)

FEATURES

- ◆ PNP Silicon Epitaxial Planar Transistors for switching and amplifier applications. Especially suitable for AF-driver stages and low-power output stages.
- ◆ These types are also available subdivided into three groups -16, -25, and -40, according to their DC current gain. As complementary types, the NPN transistors BC337 and BC338 are recommended.
- ◆ On special request, these transistors are also manufactured in the pin configuration TO-18.



MECHANICAL DATA

Case: TO-92 Plastic Package

Weight: approx. 0.18 g

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

		Symbol	Value	Unit
Collector-Emitter Voltage	BC327	$-V_{CES}$	50	V
	BC328	$-V_{CES}$	30	V
Collector-Emitter Voltage	BC327	$-V_{CEO}$	45	V
	BC328	$-V_{CEO}$	25	V
Emitter-Base Voltage		$-V_{EBO}$	5	V
Collector Current		$-I_C$	800	mA
Peak Collector Current		$-I_{CM}$	1	A
Base Current		$-I_B$	100	mA
Power Dissipation at $T_{amb} = 25\text{ °C}$		P_{tot}	625 ¹⁾	mW
Junction Temperature		T_j	150	°C
Storage Temperature Range		T_S	-65 to +150	°C

¹⁾ Valid provided that leads are kept at ambient temperature at a distance of 2 mm from case.

BC327, BC328

ELECTRICAL CHARACTERISTICS

Ratings at 25 °C ambient temperature unless otherwise specified

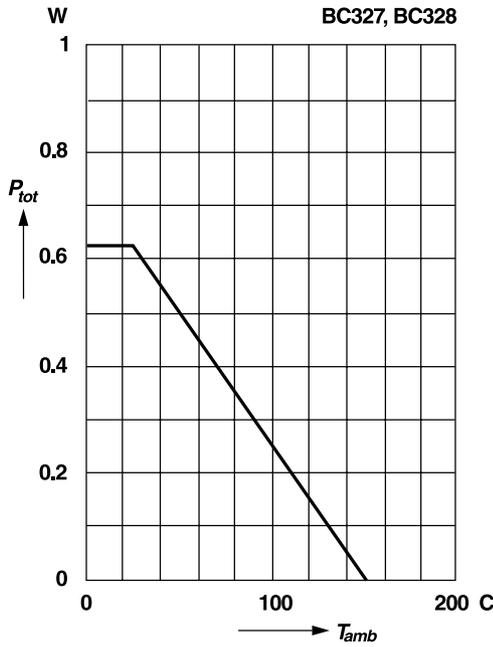
	Symbol	Min.	Typ.	Max.	Unit
DC Current Gain at $-V_{CE} = 1\text{ V}$, $-I_C = 100\text{ mA}$ Current Gain Group-16	h_{FE}	100	160	250	—
-25	h_{FE}	160	250	400	—
-40	h_{FE}	250	400	630	—
at $-V_{CE} = 1\text{ V}$, $-I_C = 300\text{ mA}$ Current Gain Group-16	h_{FE}	60	130	—	—
-25	h_{FE}	100	200	—	—
-40	h_{FE}	170	320	—	—
Thermal Resistance Junction to Ambient Air	R_{thJA}	—	—	200 ¹⁾	K/W
Collector-Emitter Cutoff Current at $-V_{CE} = 45\text{ V}$ at $-V_{CE} = 25\text{ V}$ at $-V_{CE} = 45\text{ V}$, $T_{amb} = 125\text{ °C}$ at $-V_{CE} = 25\text{ V}$, $T_{amb} = 125\text{ °C}$	BC327 $-I_{CES}$ BC328 $-I_{CES}$ BC327 $-I_{CES}$ BC328 $-I_{CES}$	— — — —	2 2 — —	100 100 10 10	nA nA μA μA
Collector-Emitter Breakdown Voltage at $-I_C = 10\text{ mA}$	BC327 $-V_{(BR)CEO}$ BC328 $-V_{(BR)CEO}$	45 25	— —	— —	V V
Collector-Emitter Breakdown Voltage at $-I_C = 0.1\text{ mA}$	BC327 $-V_{(BR)CES}$ BC328 $-V_{(BR)CES}$	50 30	— —	— —	V V
Emitter-Base Breakdown Voltage at $-I_E = 0.1\text{ mA}$	$-V_{(BR)EBO}$	5	—	—	V
Collector Saturation Voltage at $-I_C = 500\text{ mA}$, $-I_B = 50\text{ mA}$	$-V_{CEsat}$	—	—	0.7	V
Base-Emitter Voltage at $-V_{CE} = 1\text{ V}$, $-I_C = 300\text{ mA}$	$-V_{BE}$	—	—	1.2	V
Gain-Bandwidth Product at $-V_{CE} = 5\text{ V}$, $-I_C = 10\text{ mA}$, $f = 50\text{ MHz}$	f_T	—	100	—	MHz
Collector-Base Capacitance at $-V_{CB} = 10\text{ V}$, $f = 1\text{ MHz}$	C_{CBO}	—	12	—	pF

¹⁾ Valid provided that leads are kept at ambient temperature at a distance of 2 mm from case.

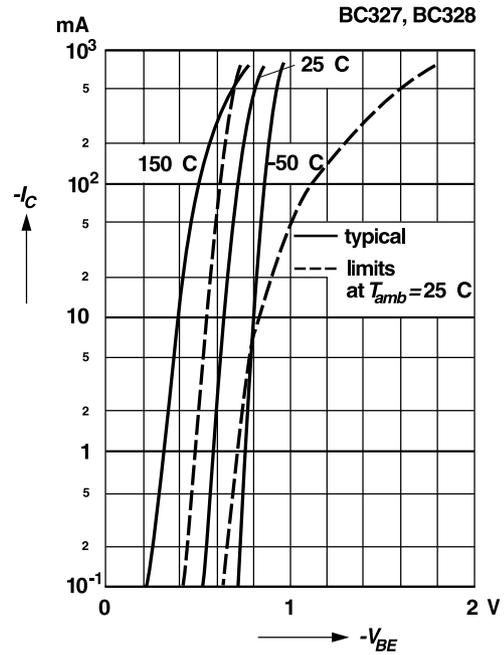
RATINGS AND CHARACTERISTIC CURVES BC327, BC328

Admissible power dissipation versus ambient temperature

Valid provided that leads are kept at ambient temperature at a distance of 2 mm from case

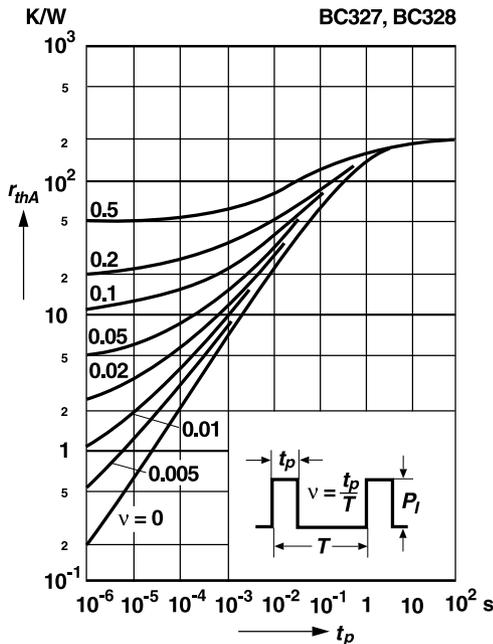


Collector current versus base-emitter voltage

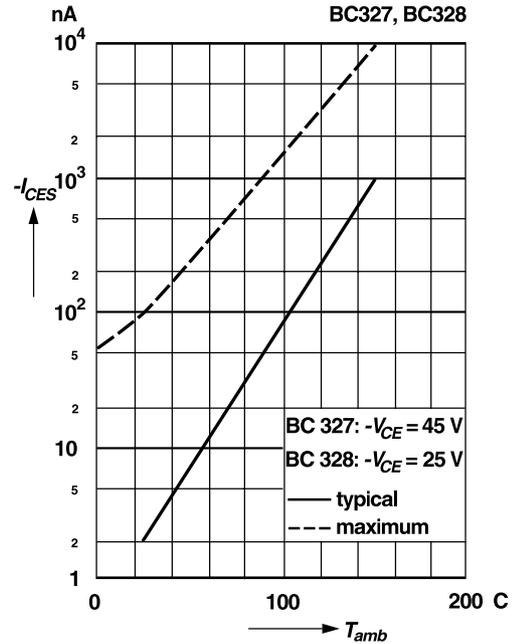


Pulse thermal resistance versus pulse duration

Valid provided that leads are kept at ambient temperature at a distance of 2 mm from case

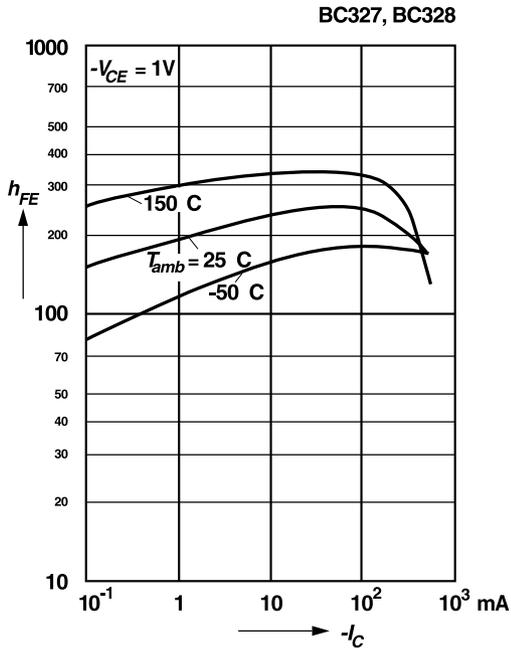


Collector-emitter cutoff current versus ambient temperature

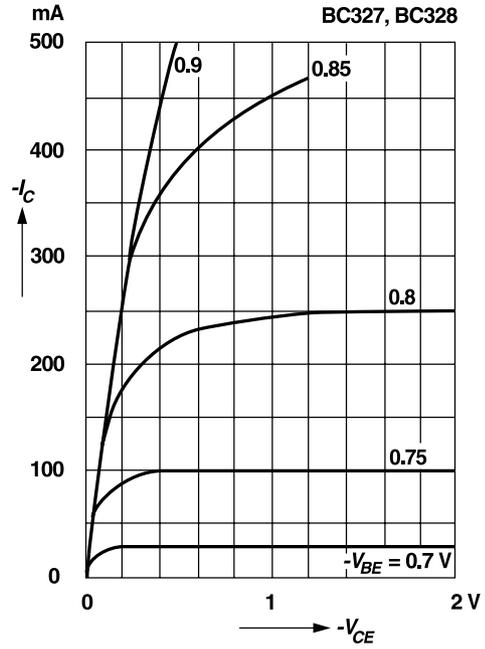


RATINGS AND CHARACTERISTIC CURVES BC327, BC328

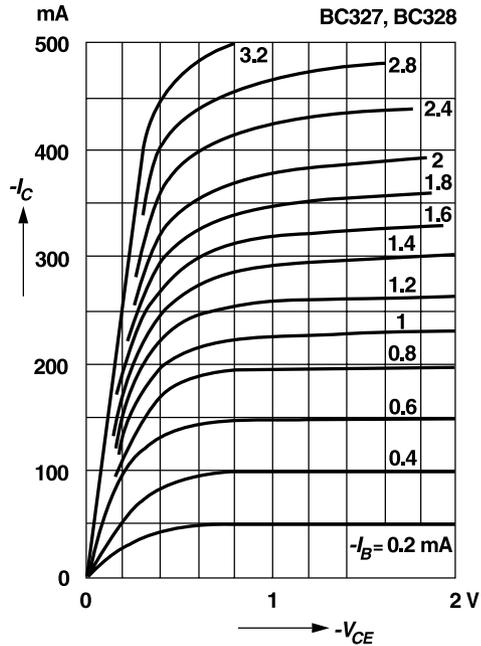
DC current gain
versus collector current



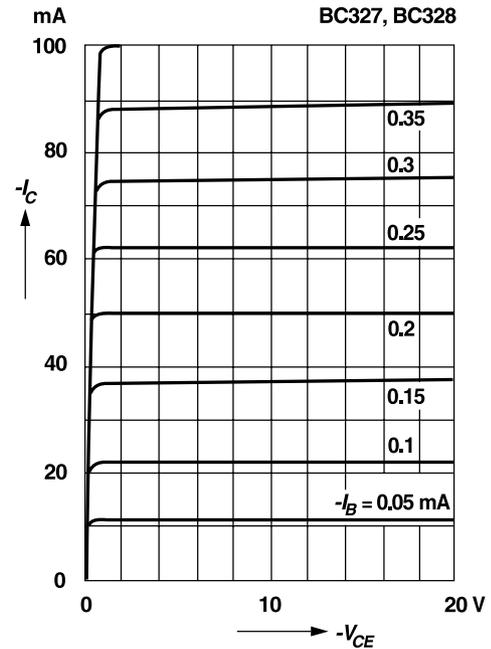
Common emitter
collector characteristics



Common emitter
collector characteristics

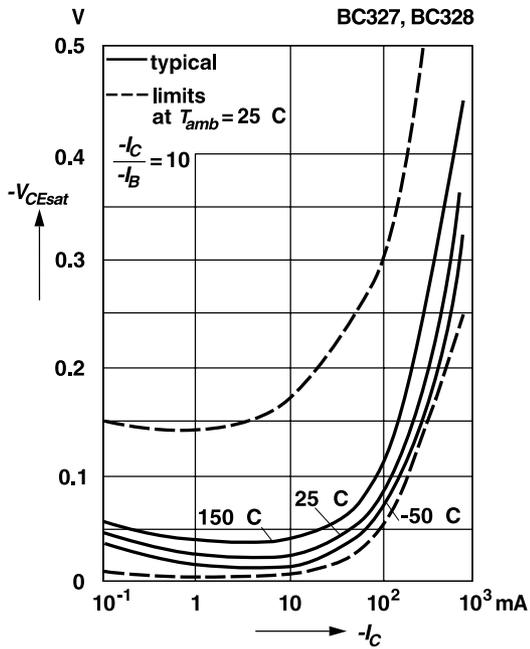


Common emitter
collector characteristics

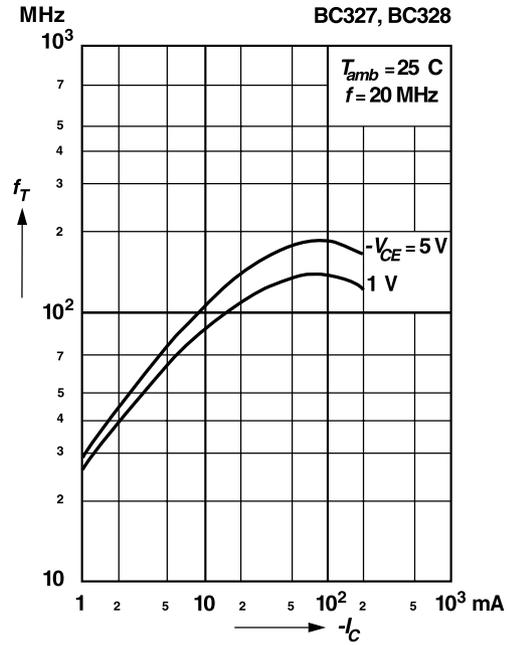


RATINGS AND CHARACTERISTIC CURVES BC327, BC328

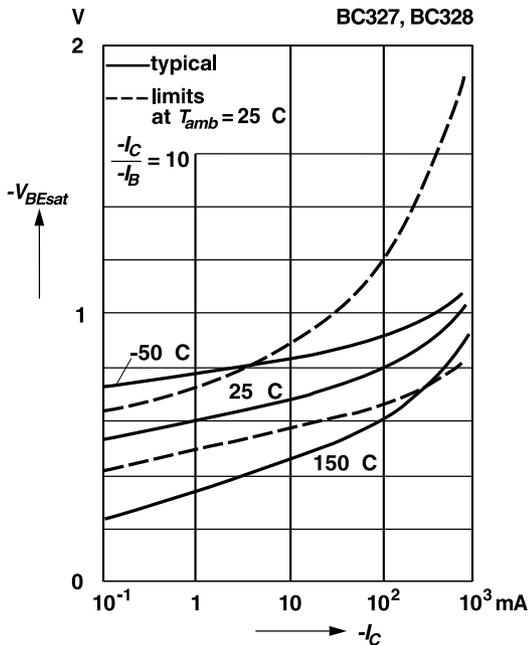
Collector saturation voltage
versus collector current



Gain-bandwidth product
versus collector current



Base saturation voltage
versus collector current



SMPS control circuit

SG3524

DESCRIPTION

This monolithic integrated circuit contains all the control circuitry for a regulating power supply inverter or switching regulator. Included in a 16-pin dual-in-line package is the voltage reference, error amplifier, oscillator, pulse-width modulator, pulse steering flip-flop, dual alternating output switches and current-limiting and shut-down circuitry. This device can be used for switching regulators of either polarity, transformer-coupled DC-to-DC converters, transformerless voltage doublers and polarity converters, as well as other power control applications. The SG3524 is designed for commercial applications of 0°C to +70°C.

FEATURES

- Complete PWM power control circuitry
- Single ended or push-pull outputs
- Line and load regulation of 0.2%
- 1% maximum temperature variation
- Total supply current is less than 10mA
- Operation beyond 100kHz

PIN CONFIGURATION

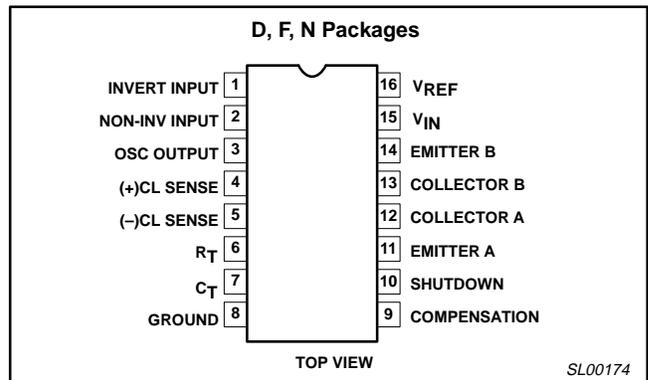


Figure 1. Pin Configuration

ORDERING INFORMATION

DESCRIPTION	TEMPERATURE RANGE	ORDER CODE	DWG #
16-Pin Plastic Dual In-Line Package (DIP)	0 to +70°C	SG3524N	SOT38-4
16-Pin Ceramic Dual In-Line Package (CERDIP)	0 to +70°C	SG3524F	0582B
16-Pin Small Outline (SO) Package	0 to +70°C	SG3524D	SOT109-1

BLOCK DIAGRAM

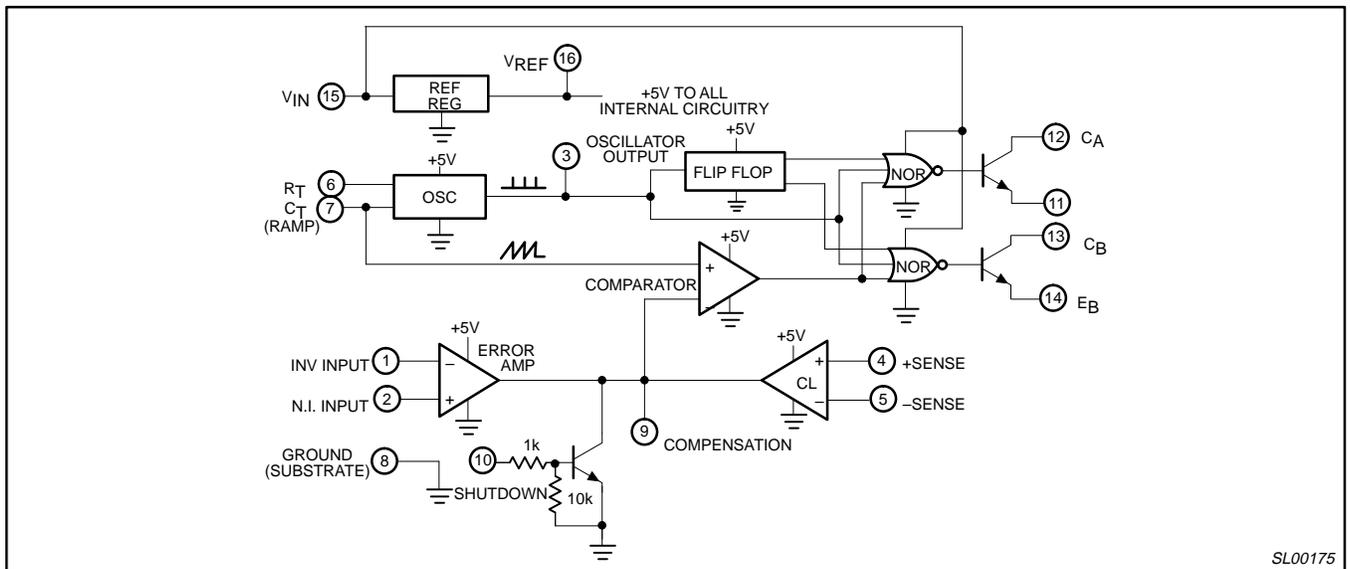


Figure 2. Block Diagram

SMPS control circuit

SG3524

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
V _{IN}	Input voltage	40	V
I _{OUT}	Output current (each output)	100	mA
I _{REF}	Reference output current	50	mA
	Oscillator charging current	5	mA
P _D	Power dissipation Package limitation Derate above 25°C	1000 8	mW mW/°C
T _A	Operating temperature range	0 to +70	°C
T _{STG}	Storage temperature range	-65 to +150	°C

DC ELECTRICAL CHARACTERISTICS

T_A=0°C to +70°C, V_{IN}=20V, and f=20kHz, unless otherwise specified.

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			Min	Typ	Max	
Reference section						
V _{OUT}	Output voltage		4.6	5.0	5.4	V
	Line regulation	V _{IN} =8 to 40V		10	30	mV
	Load regulation	I _L =0 to 20mA		20	50	mV
	Ripple rejection	f=120Hz, T _A =25°C		66		dB
I _{SC}	Short circuit current limit	V _{REF} =0, T _A =25°C		100		mA
	Temperature stability	Over operating temperature range		0.3	1	%
	Long-term stability	T _A =25°C		20		mV/kHz
Oscillator section						
f _{MAX}	Maximum frequency	C _T =0.001 μF, R _T =2kΩ		300		kHz
	Initial accuracy	R _T and C _T constant		5		%
	Voltage stability	V _{IN} =8 to 40V, T _A =25°C			1	%
	Temperature stability	Over operating temperature range			2	%
	Output amplitude	Pin 3, T _A =25°C		3.5		V _P
	Output pulse width	C _T =0.01 μF, T _A =25°C		0.5		μs
Error amplifier section						
V _{OS}	Input offset voltage	V _{CM} =2.5V		2	10	mV
I _{BIAS}	Input bias current	V _{CM} =2.5V		2	10	μA
	Open-loop voltage gain		68	80		dB
V _{CM}	Common-mode voltage	T _A =25°C	1.8		3.4	V
CMRR	Common-mode rejection ratio	T _A =25°C		70		dB
BW	Small-signal bandwidth	A _V =0dB, T _A =25°C		3		MHz
V _{OUT}	Output voltage	T _A =25°C	0.5		3.8	V
Comparator section						
	Duty cycle	% each output "ON"	0		45	%
	Input threshold	Zero duty cycle		1		V
	Input threshold	Maximum duty cycle		3.5		V
I _{BIAS}	Input bias current			1		μA
Current limiting section						
	Sense voltage	Pin 9=2V with error amplifier set for maximum out, T _A =25°C	180	200	220	mV
	Sense voltage T.C.			0.2		mV/°C
V _{CM}	Common-mode voltage		-1		+1	V

SMPS control circuit

SG3524

DC ELECTRICAL CHARACTERISTICS (Continued)

$T_A = 0^\circ\text{C}$ to $+70^\circ\text{C}$, $V_{IN} = 20\text{V}$, and $f = 20\text{kHz}$, unless otherwise specified.

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			Min	Typ	Max	
Output section (each output)						
	Collector-emitter voltage (breakdown)		40			V
	Collector-leakage current	$V_{CE}=40\text{V}$		0.1	50	μA
	Saturation voltage	$I_C=50\text{mA}$		1	2	V
	Emitter output voltage	$V_{IN}=20\text{V}$	17	18		V
t_R	Rise time	$R_C=2\text{k}\Omega$, $T_A=25^\circ\text{C}$		0.2		μs
t_F	Fall time	$R_C=2\text{k}\Omega$, $T_A=25^\circ\text{C}$		0.1		μs
Total standby current						
	(excluding oscillator charging current, error and current limit dividers, and with outputs open)	$V_{IN}=40\text{V}$		8	10	mA

THEORY OF OPERATION

Voltage Reference

An internal series regulator provides a nominal 5V output which is used both to generate a reference voltage and is the regulated source for all the internal timing and controlling circuitry. This regulator may be bypassed for operation from a fixed 5V supply by

connecting Pins 15 and 16 together to the input voltage. In this configuration, the maximum input voltage is 6.0V.

This reference regulator may be used as a 5V source for other circuitry. It will provide up to 50mA of current itself and can easily be expanded to higher currents with an external PNP as shown in Figure 3.

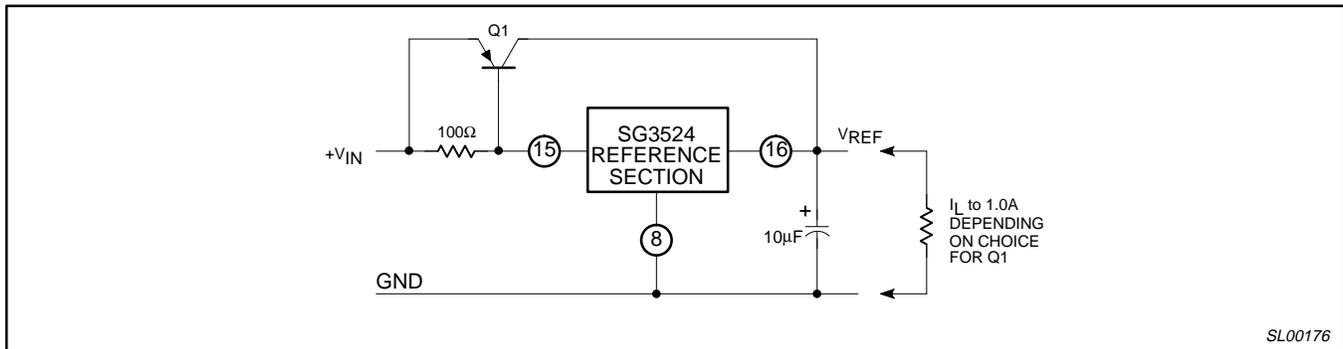


Figure 3. Expanded Reference Current Capability

TEST CIRCUIT

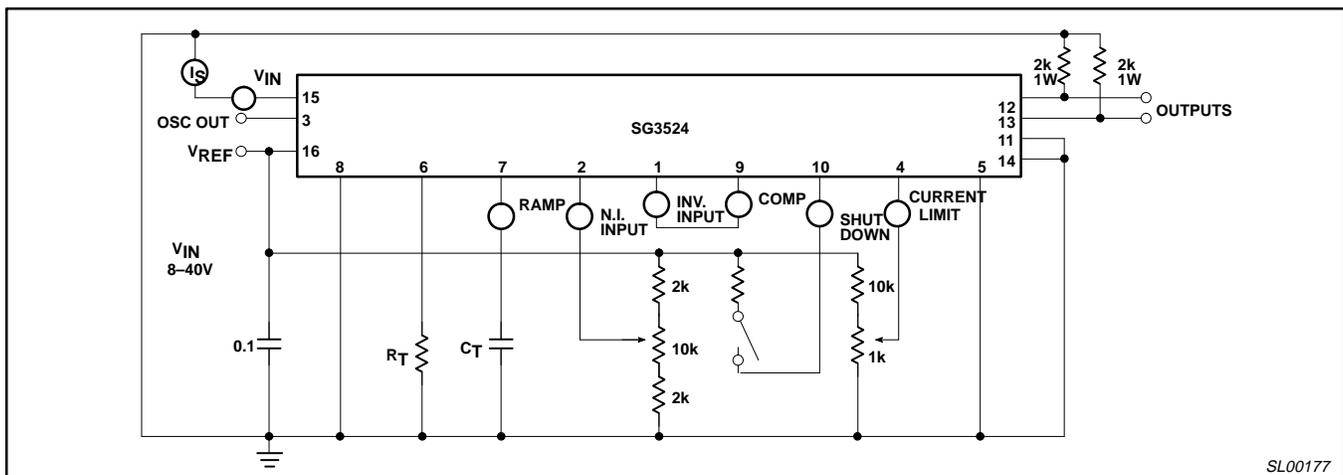


Figure 4. Test Circuit

SMPS control circuit

SG3524

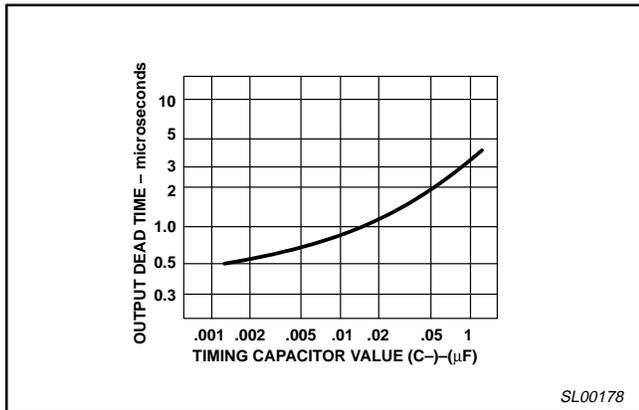


Figure 5. Output Stage Dead Time as a Function of the Timing Capacitor Value

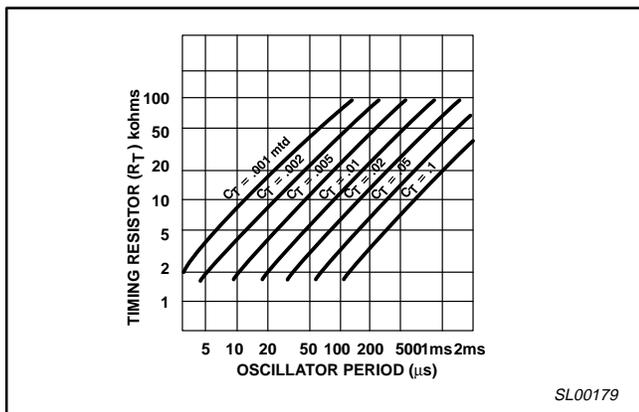


Figure 6. Oscillator Period as a Function of R_T and C_T

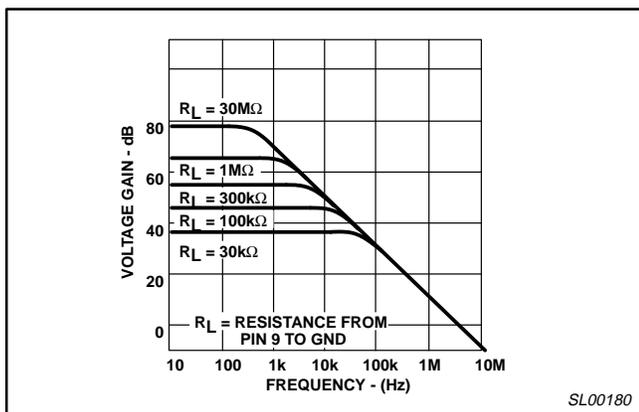


Figure 7. Amplifiers Open-Loop Gain as a Function of Frequency and Loading on Pin 9

Oscillator

The oscillator in the SG3524 uses an external resistor (R_T) to establish a constant charging current into an external capacitor (C_T). While this uses more current than a series-connected RC, it provides a linear ramp voltage on the capacitor which is also used as a reference for the comparator. The charging current is equal to

$3.6 V \div R_T$ and should be kept within the approximate range of $30\mu A$ to $2mA$; i.e., $1.8k < R_T < 100k$.

The range of values for C_T also has limits as the discharge time of C_T determines the pulse-width of the oscillator output pulse. This pulse is used (among other things) as a blanking pulse to both outputs to insure that there is no possibility of having both outputs on simultaneously during transitions. This output dead time relationship is shown in Figure 5. A pulse width below approximately $0.5\mu s$ may allow false triggering of one output by removing the blanking pulse prior to the flip-flop's reaching a stable state. If small values of C_T must be used, the pulse-width may still be expanded by adding a shunt capacitance ($\approx 100pF$) to ground at the oscillator output. [(Note: Although the oscillator output is a convenient oscilloscope sync input, the cable and input capacitance may increase the blanking pulse-width slightly.)] Obviously, the upper limit to the pulse width is determined by the maximum duty cycle acceptable. Practical values of C_T fall between 0.001 and $0.1\mu F$.

The oscillator period is approximately $t = R_T C_T$ where t is in microseconds when $R_T = \Omega$ and $C_T = \mu F$. The use of Figure 6 will allow selection of R_T and C_T for a wide range of operating frequencies. Note that for series regulator applications, the two outputs can be connected in parallel for an effective 0-90% duty cycle and the frequency of the oscillator is the frequency of the output. For push-pull applications, the outputs are separated and the flip-flop divides the frequency such that each output's duty cycle is 0-45% and the overall frequency is one-half that of the oscillator.

External Synchronization

If it is desired to synchronize the SG3524 to an external clock, a pulse of $\approx +3V$ may be applied to the oscillator output terminal with $R_T C_T$ set slightly greater than the clock period. The same considerations of pulse-width apply. The impedance to ground at this point is approximately $2k\Omega$.

If two or more SG3524s must be synchronized together, one must be designated as master with its $R_T C_T$ set for the correct period. The slaves should each have an $R_T C_T$ set for approximately 10% longer period than the master with the added requirement that $C_T(\text{slave}) = \text{one-half } C_T(\text{master})$. Then connecting Pin 3 on all units together will insure that the master output pulse—which occurs first and has a wider pulse width—will reset the slave units.

Error Amplifier

This circuit is a simple differential input transconductance amplifier. The output is the compensation terminal, Pin 9, which is a high-impedance node ($R_L \approx 5M\Omega$). The gain is

$$A_v = g_m R_L = \frac{8 I_C R_L}{2kT} \approx 0.002 R_L$$

and can easily be reduced from a nominal of 10,000 by an external shunt resistance from Pin 9 to ground, as shown in Figure 7.

In addition to DC gain control, the compensation terminal is also the place for AC phase compensation. The frequency response curves of Figure 7 show the uncompensated amplifier with a single pole at approximately 200Hz and a unity gain crossover at 5MHz.

Typically, most output filter designs will introduce one or more additional poles at a significantly lower frequency. Therefore, the best stabilizing network is a series RC combination between Pin 9 and ground which introduces a zero to cancel one of the output filter poles. A good starting point is $50k\Omega$ plus $0.001\mu F$.

SMPS control circuit

SG3524

One final point on the compensation terminal is that this is also a convenient place to insert any programming signal which is to override the error amplifier. Internal shutdown and current limit circuits are connected here, but any other circuit which can sink 200µA can pull this point to ground, thus shutting off both outputs.

While feedback is normally applied around the entire regulator, the error amplifier can be used with conventional operational amplifier feedback and is stable in either the inverting or non-inverting mode. Regardless of the connections, however, input common-mode limits must be observed or output signal inversions may result. For conventional regulator applications, the 5V reference voltage must be divided down as shown in Figure 8. The error amplifier may also be used in fixed duty cycle applications by using the unity gain configuration shown in the open-loop test circuit.

Current Limiting

The current limiting circuitry of the SG3524 is shown in Figure 9.

By matching the base-emitter voltages of Q1 and Q2, and assuming a negligible voltage drop across R₁:

$$\text{Threshold} = V_{BE}(Q1) + I_1 R_2 - V_{BE}(Q2)$$

$$= I_1 R_2 \cong 200\text{mV}$$

Although this circuit provides a relatively small threshold with a negligible temperature coefficient, there are some limitations to its use, the most important of which is the ±1V common-mode range which requires sensing in the ground line. Another factor to consider is that the frequency compensation provided by R₁C₁ and Q1 provides a roll-off pole at approximately 300Hz.

Since the gain of this circuit is relatively low, there is a transition region as the current limit amplifier takes over pulse width control from the error amplifier. For testing purposes, threshold is defined as the input voltage required to get 25% duty cycle with the error amplifier signaling maximum duty cycle.

In addition to constant current limiting, Pins 4 and 5 may also be used in transformer-coupled circuits to sense primary current and to shorten an output pulse, should transformer saturation occur. Another application is to ground Pin 5 and use Pin 4 as an additional shutdown terminal: i.e., the output will be off with Pin 4 open and on when it is grounded. Finally, foldback current limiting can be provided with the network of Figure 10. This circuit can reduce the short-circuit current (I_{SC}) to approximately one-third the maximum available output current (I_{MAX}).

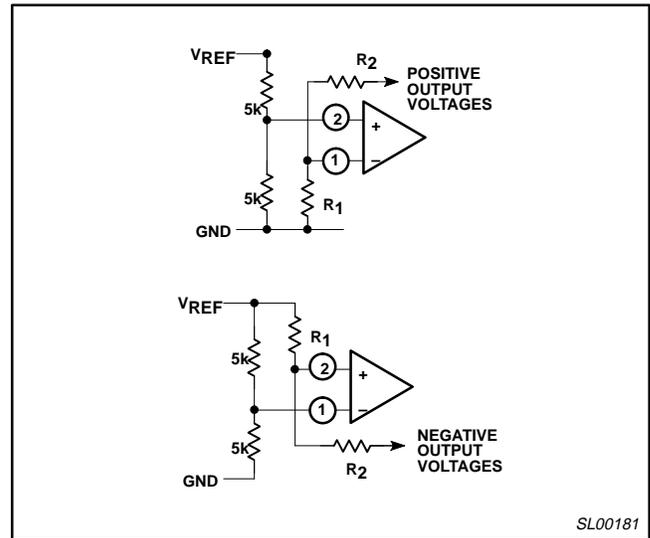


Figure 8. Error Amplifier Biasing Circuits

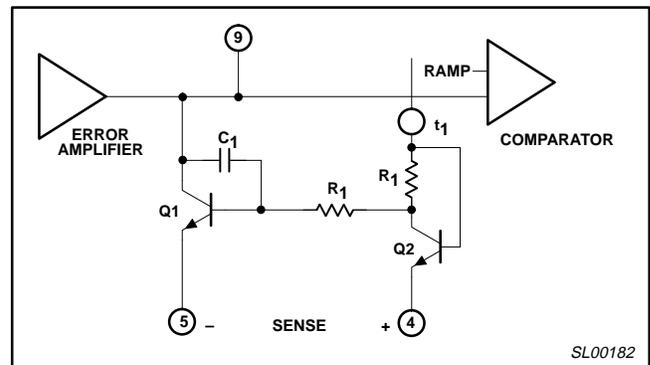


Figure 9. Current Limiting Circuitry of the SG3524

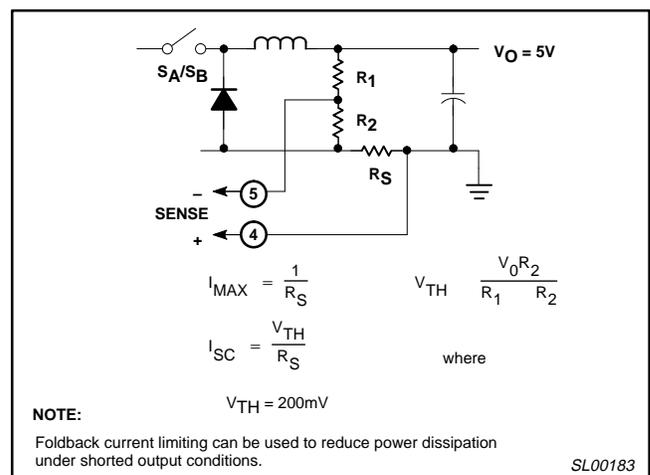
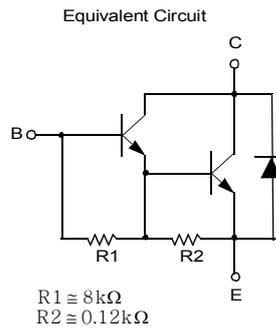
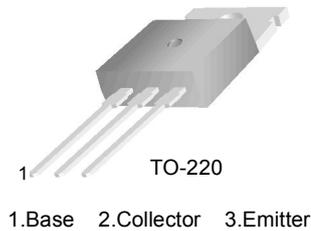


Figure 10. Foldback Current Limiting

TIP120/TIP121/TIP122

NPN Epitaxial Darlington Transistor

- Medium Power Linear Switching Applications
- Complementary to TIP125/126/127



Absolute Maximum Ratings* $T_a = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{CBO}	Collector-Base Voltage : TIP120	60	V
	: TIP121	80	V
	: TIP122	100	V
V_{CEO}	Collector-Emitter Voltage : TIP120	60	V
	: TIP121	80	V
	: TIP122	100	V
V_{EBO}	Emitter-Base Voltage	5	V
I_C	Collector Current (DC)	5	A
I_{CP}	Collector Current (Pulse)	8	A
I_B	Base Current (DC)	120	mA
P_C	Collector Dissipation ($T_a=25^\circ\text{C}$)	2	W
	Collector Dissipation ($T_C=25^\circ\text{C}$)	65	W
T_J	Junction Temperature	150	$^\circ\text{C}$
T_{STG}	Storage Temperature	- 65 ~ 150	$^\circ\text{C}$

* These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

Electrical Characteristics* $T_a=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Units
$V_{\text{CEO(sus)}}$	Collector-Emitter Sustaining Voltage : TIP120 : TIP121 : TIP122	$I_C = 100\text{mA}, I_B = 0$	60 80 100			V V V
I_{CEO}	Collector Cut-off Current : TIP120 : TIP121 : TIP122	$V_{\text{CE}} = 30\text{V}, I_B = 0$ $V_{\text{CE}} = 40\text{V}, I_B = 0$ $V_{\text{CE}} = 50\text{V}, I_B = 0$			0.5 0.5 0.5	mA mA mA
I_{CBO}	Collector Cut-off Current : TIP120 : TIP121 : TIP122	$V_{\text{CB}} = 60\text{V}, I_E = 0$ $V_{\text{CB}} = 80\text{V}, I_E = 0$ $V_{\text{CB}} = 100\text{V}, I_E = 0$			0.2 0.2 0.2	mA mA mA
I_{EBO}	Emitter Cut-off Current	$V_{\text{BE}} = 5\text{V}, I_C = 0$			2	mA
h_{FE}	* DC Current Gain	$V_{\text{CE}} = 3\text{V}, I_C = 0.5\text{A}$ $V_{\text{CE}} = 3\text{V}, I_C = 3\text{A}$	1000 1000			
$V_{\text{CE(sat)}}$	* Collector-Emitter Saturation Voltage	$I_C = 3\text{A}, I_B = 12\text{mA}$ $I_C = 5\text{A}, I_B = 20\text{mA}$			2.0 4.0	V V
$V_{\text{BE(on)}}$	* Base-Emitter On Voltage	$V_{\text{CE}} = 3\text{V}, I_C = 3\text{A}$			2.5	V
C_{ob}	Output Capacitance	$V_{\text{CB}} = 10\text{V}, I_E = 0, f = 0.1\text{MHz}$			200	pF

* Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%

Typical characteristics

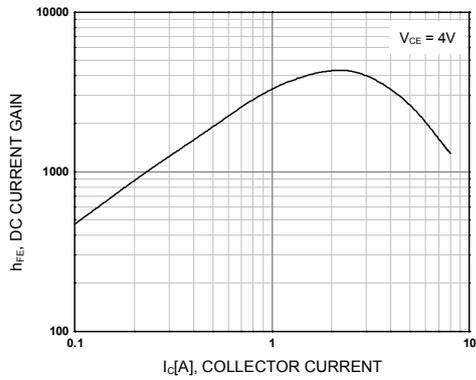


Figure 1. DC current Gain

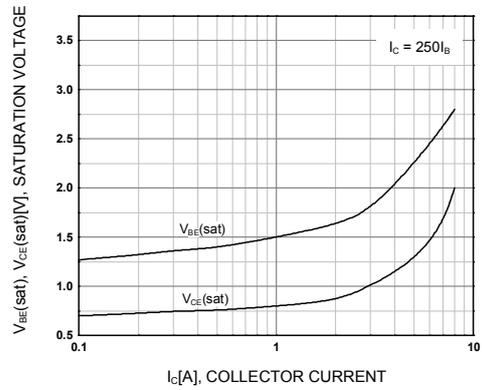


Figure 2. Base-Emitter Saturation Voltage
Collector-Emitter Saturation Voltage

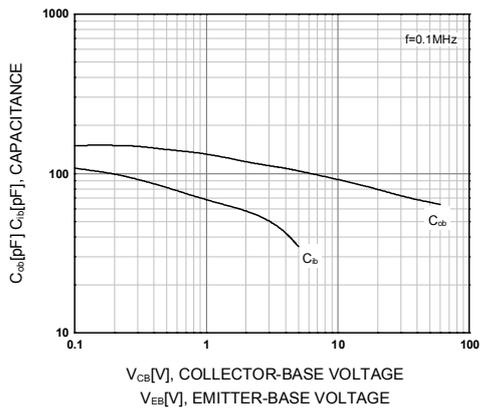


Figure 3. Output and Input Capacitance
vs. Reverse Voltage

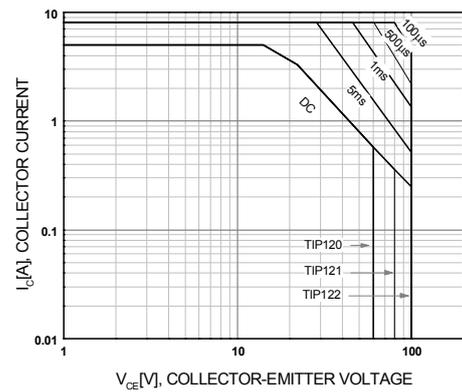


Figure 4. Safe Operating Area

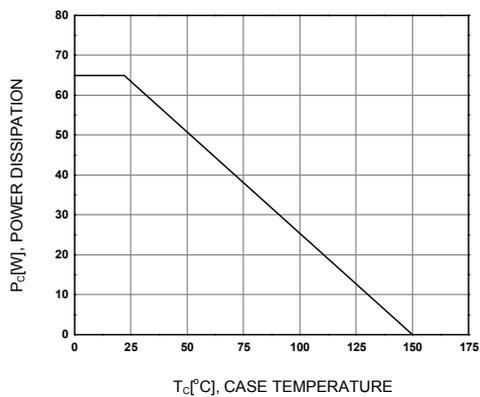


Figure 5. Power Derating



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| Current Transfer Logic™ | ISOPLANAR™ | QFET® | TinyBuck™ |
| EcoSPARK® | MegaBuck™ | QS™ | TinyLogic® |
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| FastvCore™ | OPTOPLANAR® | SuperFET™ | UniFET™ |
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